



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Max Shurgalin et al.                      Art Unit : 2877  
Serial No. : 10/068,998                                  Examiner : Tu T. Nguyen  
Filed : February 7, 2002  
Title : OPTICAL WAVEGUIDE MONITORING

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

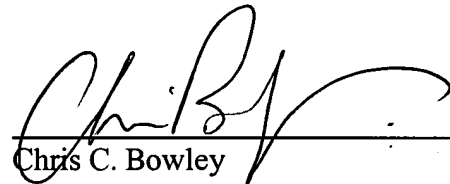
INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. A check for \$180 in payment of the late submission fee of §1.17(p) is enclosed. Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: April 16, 2004

  
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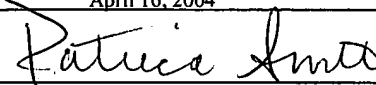
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Substitute Form PTO-1449

U.S. Department of Commerce  
Patent and Trademark Office

Attorney's Docket No.

13445-006001

Application No.

10/068,998

**Information Disclosure Statement  
by Applicant**

(Use several sheets if necessary)

Applicant

Max Shurgalin et al.

Filing Date

February 7, 2002

Group Art Unit

2877

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,289,265	02/22/94	Inoue et al.			

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AB							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AC	

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Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.